Notice of References Cited Application/Control No. 10/707,545 Examiner Seung H. Lee Applicant(s)/Patent Under Reexamination MUGICA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,460,770	10-2002	Kucharczyk, David	235/472.02
	В	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
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	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

1		Document Number	Date			
*		Country Code-Number-Kind Code	MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
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	S					
	Т					

NON-PATENT DOCUMENTS

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*	-	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.